



### 65V P-CHANNEL ENHANCEMENT MODE MOSFET

## **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D Max</sub> T <sub>A</sub> = +25°C
-65V	8Ω @ V <sub>GS</sub> = -5V	-318mA
	18Ω @ V <sub>GS</sub> = -2.5V	-212mA

### **Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative. https://www.diodes.com/quality/product-definitions/

## **Description and Applications**

This new generation MOSFET is designed to minimize the on-state resistance (R<sub>DS(ON)</sub>) yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- DC-DC Converters
- Power Management Functions
- Battery Operated Systems and Solid-State Relays
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc.

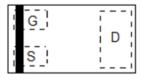
### **Mechanical Data**

- Case: X1-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound;
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu. Solderable per MIL-STD-202, Method 208 @4)
- Weight: 0.001 grams (Approximate)

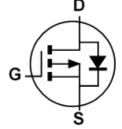
#### X1-DFN1006-3



**Bottom View** 



Top View Pin-Out



Equivalent Circuit

### Ordering Information (Note 4)

Part Number	Case	Packaging
DMP68D0LFB-7B	X1-DFN1006-3	10,000 / Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

## **Marking Information**



Bar Denotes Gate and Source Side

### X1-DFN1006-3

NX= Part Marking Code



# **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	VDSS	-65	V		
Gate-Source Voltage	V <sub>GSS</sub>	±20	V		
Continuous Drain Current (Note 5) Vgs = -5V	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	lo	-192 -153	mA
Continuous Drain Current (Note 6) Vgs = -5V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	lo	-318 -254	mA
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%	I <sub>DM</sub>	-800	mA		
Maximum Body Diode Continuous Current (Note 6)			Is	-318	mA

## **Thermal Characteristics**

Characteristic	Symbol	Max	Unit
Power Dissipation (Note 5)	PD	0.5	W
Thermal Resistance, Junction to Ambient @T <sub>A</sub> = +25°C (Note 5)	Reja	251	°C/W
Power Dissipation (Note 6)	PD	1.21	W
Thermal Resistance, Junction to Ambient @T <sub>A</sub> = +25°C (Note 6)	$R_{\theta JA}$	103	°C/W
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

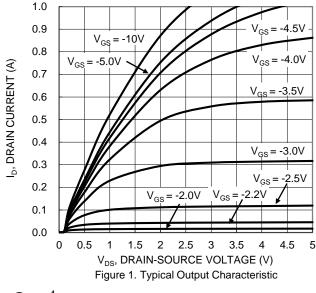
# **Electrical Characteristics** (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-65	_	_	V	Vgs = 0V, ID = -250µA	
Zero Gate Voltage Drain Current	IDSS	_	_	-1.0	μA	V <sub>DS</sub> = -65V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-0.8		-2.1	٧	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance	Dagger	_	2.0	8	Ω	$V_{GS} = -5V, I_{D} = -100mA$	
Static Diani-Source On-Resistance	Rds(on)	_	4.7	18	Ω	$V_{GS} = -2.5V, I_{D} = -10mA$	
Diode Forward Voltage	VsD	_	-0.8	-1.5	V	V <sub>G</sub> S = 0V, I <sub>S</sub> = -100mA	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C <sub>iss</sub>	_	36	_		V 201/ W 21/	
Output Capacitance	Coss	_	3.9		pF	$V_{DS} = -30V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	Crss	_	2.1	_		I = 1.0IVII IZ	
Gate Resistance	Rg	_	247	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge	Qg	_	4.1	_		., 5)/ )/ 00)/	
Gate-Source Charge	Qgs	_	1.3	_	nC	$V_{GS} = -5V, V_{DS} = -30V,$ $I_{D} = -100 \text{mA}$	
Gate-Drain Charge	Qgd	_	1.3	_		ID = - TOUTIA	
Turn-On Delay Time	t <sub>D(ON)</sub>	_	12.2	_			
Turn-On Rise Time	t <sub>R</sub>	_	10.6	_		$V_{GS} = -5V, V_{DS} = -30V,$	
Turn-Off Delay Time	tD(OFF)	_	33.2	_	ns	$R_G = 50\Omega$ , $I_D = -100 \text{mA}$	
Turn-Off Fall Time	t <sub>F</sub>	_	18.9	_			

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate.
  7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to production testing.





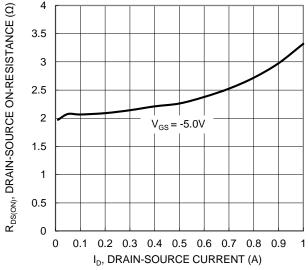


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

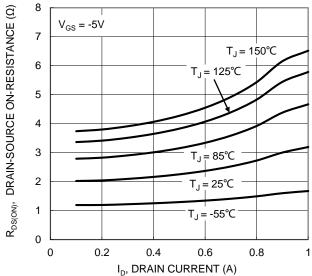
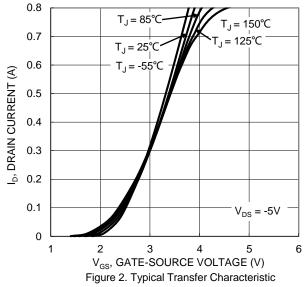
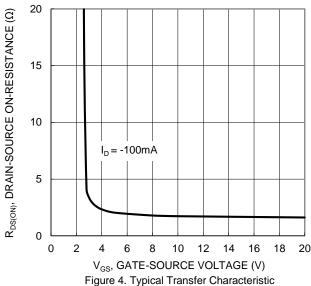


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature





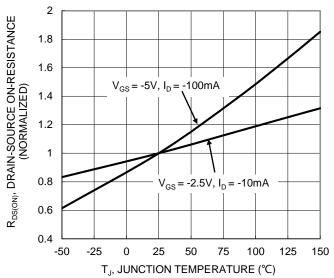


Figure 6. On-Resistance Variation with Junction Temperature



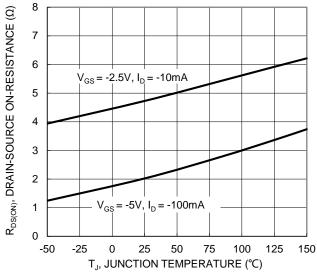


Figure 7. On-Resistance Variation with Junction Temperature

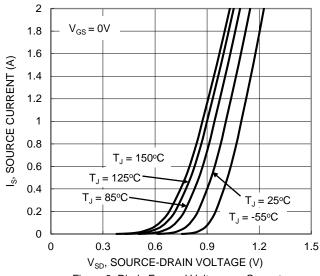
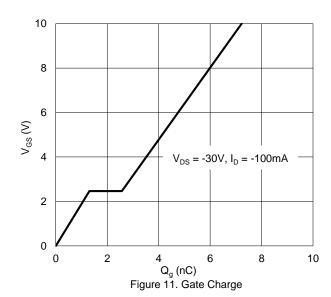
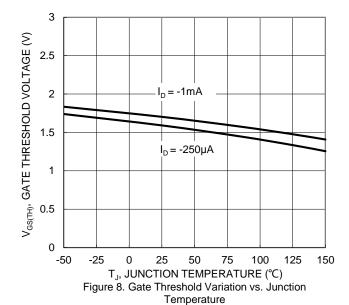
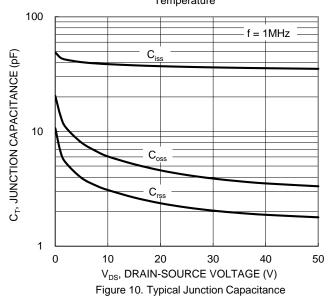
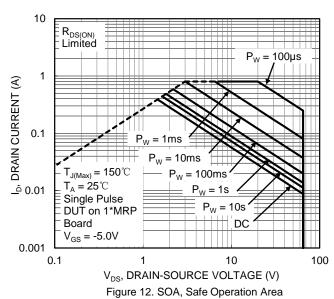


Figure 9. Diode Forward Voltage vs. Current











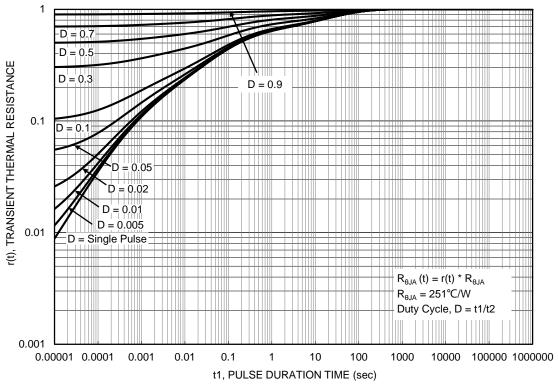


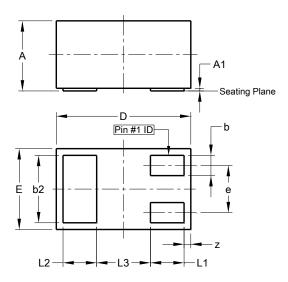
Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### X1-DFN1006-3

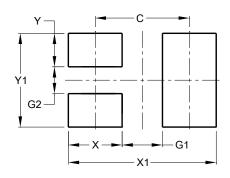


X1-DFN1006-3					
Dim	Min	Max	Тур		
Α	0.47	0.53	0.50		
A1	0.00	0.05	0.03		
b	0.10	0.20	0.15		
b2	0.45	0.55	0.50		
D	0.95	1.075	1.00		
E	0.55	0.675	0.60		
е	•	-	0.35		
L1	0.20	0.30	0.25		
L2	0.20	0.30	0.25		
L3	-	-	0.40		
Z	0.02	0.08	0.05		
All Dimensions in mm					

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### X1-DFN1006-3



Dimensions	Value (in mm)			
С	0.70			
G1	0.30			
G2	0.20			
Х	0.40			
X1	1.10			
Y	0.25			
Y1	0.70			

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